High-pressure Raman spectroscopy in the layered materials 2*H*-MoS₂, 2*H*-MoSe₂, and 2*H*-MoTe₂

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Lattice vibrations were investigated by Raman spectroscopy in the layered materials 2H-MoS₂ up to 180 kbar, 2H-MoSe₂ up to 180 kbar, and 2H-MoTe₂ up to 80 kbar. One A_{1g} and two E_{2g} modes were observed. The energies of the rigid-layer modes rapidly increase with pressure, but the increase becomes slow above 50 kbar. The interlayer and intralayer shear force constants are obtained as a function of pressure with the use of the linear-chain model.

INTRODUCTION

Transition-metal dichalcogenides have a typical layered crystal structure.¹ The two-dimensional lattice vibration is an interesting subject in conjunction with two-dimensional electronic-band structure and the effect of intercalation. The transition-metal IV dichalcogenides (TiX_2, ZrX_2, HfX_2) , and the transition-metal VI dichalcogenides (MoX_2, WX_2) are all semiconductors with the exception of semimetallic TiSe₂.² The transition-metal V dichalcogenides (VX_2, NbX_2, TaX_2) are metallic and show the charge-density-wave phase transition due to the unique properties of the two-dimensional electronic-band structure.³ These compounds are polymorphic. The basic structures are 1T and 2Hstructures. The molybdenum dichalcogenides crystallize in the 2H structure. In this structure the metal atom is surrounded by a trigonal prism of six chalcogen atoms. For molybdenum ditelluride there exists another structure, called the β structure, besides the normal α structure. In the β 2H structure, the metal atoms are located at deformed positions from the flat plane perpendicular to the c axis¹ and shows a phase transition at low temperatures.^{4,5} The interlayer distances of these materials are large and the interlayer binding force comes from van der Waals force. The binding force between the interlayer chalcogen atoms are 2% or 3% of that between the intralayer metal and chalcogen atoms. The interlayer distance can be easily changed by external force applied to the crystal. We applied hydrostatic pressure to the crystal and observed the change of the inter- and intralayer forces through the lattice vibration.

The space group of 2H-Mo X_2 is D_{6h}^4 and one unit cell contains two molecules. The long-

wavelength optical phonons $\operatorname{are}^{6}A_{1g} + A_{2u} + B_{1u}$ +2 $B_{2g} + E_{1g} + E_{1u} + 2E_{2g} + E_{2u}$. The A_{2u} and E_{1u} modes are infrared active and the A_{1g} , E_{1g} , and E_{2g} modes are Raman active. In these crystals one unit cell contains two layers, and therefore the rigid-layer mode locates at the Γ point. The rigid-layer mode is the characteristic low-frequency mode reflecting the weak van der Waals binding force.⁷ One of the B_{2g} and one of the E_{2g} modes correspond to this mode. The Raman active normal modes are shown in Fig. 1.

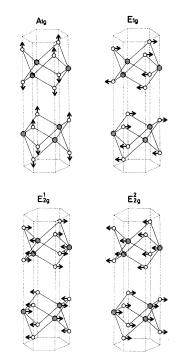


FIG. 1. Raman-active normal modes in 2H-Mo X_2 . The large shaded circles represent molybdenum atoms and the small circles chalcogen atoms. The E_{2g}^2 mode is the rigid-layer mode.

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At atmospheric pressure the lattice vibration has been observed by Raman scattering^{6,8-15} and infrared spectroscopy.^{8,16,17} Neutron-diffraction measurement¹⁸ has been done in 2*H*-MoS₂. Highpressure Raman scattering up to 50 kbar has been done in 2*H*-MoS₂,¹⁹ and the energy shift of the A_{1g} and E_{2g} modes, except the rigid-layer mode, have been observed. The electric resistivity, x-ray diffraction, and absorption spectra have been measured under high pressure in 2*H*-MoS₂.²⁰⁻²³ In this experiment, we measured the change of the energies of the A_{1g} and E_{2g} modes, including the rigid-layer mode up to 180 kbar in 2*H*-MoS₂ and 2*H*-MoSe₂ and up to 80 kbar in α -2*H*-MoTe₂, and we observed the change of interlayer van der Waals force and the intralayer binding force.

EXPERIMENTAL DETAILS AND RESULTS

Natural crystals were used for 2H-MoS₂. The crystals of 2*H*-MoSe₂ and α -2*H*-MoTe₂ were grown by the chemical transport method using bromine as the transport agent. The hydrostatic high pressure was generated by a diamond anvil cell. The flat surface of the diamond generating high pressure was 0.6 mm in diameter. The metal gasket was made with Udimet 700, and had a hole of 200 μ m. The pressure was measured from the wavelength shift of the R_1 luminescence line of ruby.²⁴ A mixture of methanol and ethanol (4:1) was used as the pressure transmitting liquid. This mixture becomes solid above about 100 kbar. In order to prevent pressure inhomogeneity, a small sample of $50 \times 50 \times 5 \ \mu m^3$ and small ruby chips of 10 μ m in diameter were used. The Raman scattering experiment was executed in a back-scattering configuration at room temperature. A 100-mW 5145-Å Ar-ion laser, a double monochromator Spex 1400 with holographic gratings and a computer-controlled photon-counting system were used. The cleaved surfaces of MoX_2 were used, and therefore the A_{1g} and E_{2g} modes are observable in this experimental configuration.

Figures 2(a), 2(b), and 2(c) show the pressure dependence of the phonon energies of the A_{1g} and E_{2g} modes in 2*H*-MoS₂, 2*H*-MoSe₂, and α -2*H*-MoTe₂, respectively. The lowest energy modes E_{2g}^2 are the rigid-layer modes. These energies increase rapidly with an increase of pressure, but the speed of the increase becomes slow above 50 kbar. The phonon energies at atmospheric pressure and the pressure derivatives near atmospheric pressure are listed in Table I with the values of other authors.

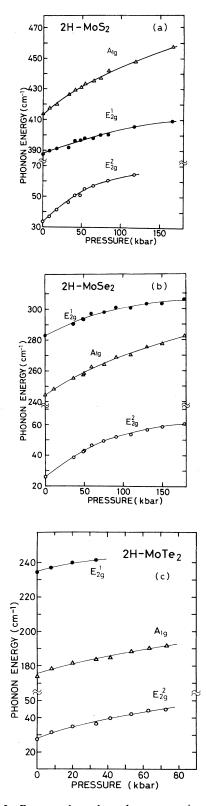


FIG. 2. Pressure-dependent phonon energies of the A_{1g} and E_{2g} modes in 2*H*-MoS₂ (a), 2*H*-MoSe₂ (b), and α -2*H*-MoTe₂ (c).

		Units	$2H-MoS_2$	$2H-MoSe_2$	α -2 <i>H</i> -MoTe ₂
Lattice constant ^a	a	ÅÅ	3.160	3.288	3.517
	с	Å	2×6.147	2×6.460	2×6.981
	c /2a		1.945	1.962	1.984
Intralayer height ^a	X - M	ÅÅ	3.19	3.23	3.63
		Å	2.41	2.49 ?	2.73
van der Waals gap		Å	2.96	3.22	3.35
height ^a	X - X	Å	3.47	3.75	3.92
$2 \times$ van der Waals radius of X		Å	3.70	4.00	4.40
Initial compressi-	Ka	kbar ⁻¹	3.4×10 ⁻⁴		
bility ^b	K _c		16.4×10^{-4}		
	K		23.2×10^{-4}		
Phonon energy	$\omega(a_{1g})$	cm^{-1}	413	244	174
	.9		409°	243.1 ^d	171.4 ^d
	$\omega(A_{2u})$		470 ^c	350 ^e	
	$\omega(E_{1g})$		287°	168.8 ^d	116.8 ^d
	$\omega(E_{1u})$		384°	286.0 ^d	234.5 ^d
	$\omega(E_{2g}^1)$		387	283	234
	ω (2 2g)		383°	283 ^d	232.4 ^d
	$\omega(E_{2g}^2)$		33.5	26	27.5
			33.7 ^f	26.9 ^d	25.4 ^d
	$\partial \omega(A_{1g})/\partial P$	$cm^{-1}kbar^{-1}$	0.40	0.31	0.26
	18		0.37 ^g		
	$\partial \omega(E_{2g}^1)/\partial P$		0.19	0.23	0.26
	-8		0.18 ^g		
	$\partial \omega(E_{2g}^2)/\partial P$		0.45	0.36	0.37
Grüneisen constant	$\gamma(A_{1g})$		0.42		
	$\gamma(E_{2g}^{1})$		0.21		
	$\gamma(E_{2g}^{2})$		5.8		
Force constant	C_b^s	dyne cm^{-1}	2.7×10^{3}	2.6×10 ³	3.9×10 ³
	$\partial C_b^s / \partial P$	$dynecm^{-1}kbar^{-1}$	70	80	110
	C_w^s	dyne cm ⁻¹	1.7×10^{5}	1.4×10 ⁵	1.1×10 ⁵
	$C_w^s \ \partial C_w^s / \partial P$	$dynecm^{-1}kbar^{-1}$	110	210	230
	C_b^s/C_w^s		1.6×10^{-2}	1.8×10 ⁻²	3.5×10 ⁻²
	$\partial (C_b^s/C_w^s)/P$	kbar ⁻¹	4×10 ⁻⁴	5×10 ⁻⁴	9×10 ⁻⁴
^a Reference 1. ^b Reference 23.	^d Reference 14. ^e Reference 16.	^f Reference 9. ^g Reference 19.			

TABLE I. Lattice constants, compressibilities, phonon energies and their pressure derivatives, and interlayer and intralayer shear force constants and their pressure derivatives in 2H-MoX₂.

The energies at atmospheric pressure are in good agreement with the data of Wieting *et al.*,¹⁴ and the pressure derivative of the A_{1g} and E_{2g}^1 modes in 2*H*-MoS₂ are in good agreement with the data

^cReference 8.

of Bagnall *et al.*¹⁹ with the use of the data of Webb *et al.*²³ for the compressibility in 2*H*-MoS₂, the mode-Grüneisen constant was calculated as 5.8 for the rigid-layer E_{2g}^2 mode. This value is much

larger than the value 0.42 for the A_{1g} mode and 0.21 for the E_{2g}^1 mode.

DISCUSSION

Many models have been proposed to calculate the lattice vibration.^{9,18,25,26} Wakabayashi¹⁸ showed the necessity of the bond-bending forces and the non-nearest-neighbor interatomic forces coming from the covalent bond between the intralayer atoms, in order to reproduce the phonon dispersion curve observed by his neutron scattering experiment. In this paper a simple linear-chain model proposed by Wieting²⁶ was adopted. The shear and compressive force constants between the chalcogen planes of the neighboring layers are expressed by C_b^s and C_b^c , respectively. The shear and compressive force constants between the molybdenum and chalcogen planes in a layer are expressed by C_w^s and C_w^c , respectively. The energy of the A_{1g} and E_{2g} modes are

$$\begin{split} \omega^{2}(A_{1g}) &= \frac{C_{w}^{c} + 2C_{b}^{c}}{M_{x}} ,\\ \omega^{2}(E_{2g}^{1}) &= \frac{C_{w}^{s}}{2M} + \frac{C_{b}^{s}}{M_{x}} \\ &+ \left[\left[\frac{C_{w}^{s}}{2M} + \frac{C_{b}^{s}}{M_{x}} \right]^{2} - \frac{4C_{w}^{s}C_{b}^{s}}{M_{m}M_{x}} \right]^{1/2} \\ &\approx \frac{C_{w}^{s}}{M} \left[1 + \frac{2M^{2}}{M_{x}^{2}} \left[\frac{C_{b}^{s}}{C_{w}} \right] \right] ,\\ \omega^{2}(E_{2g}^{2}) &= \frac{C_{w}^{s}}{2M} + \frac{C_{b}^{s}}{M_{x}} \\ &- \left[\left[\frac{C_{w}^{s}}{2M} + \frac{C_{b}^{s}}{M_{x}} \right]^{2} - \frac{4C_{w}^{s}C_{b}^{s}}{M_{m}M_{x}} \right]^{1/2} \\ &\approx \frac{4C_{b}^{s}}{M_{m} + 2M_{x}} , \end{split}$$

where M_m and M_x are the atomic masses of molybdenum and chalcogen atoms, and

$$M = M_m M_x / (M_m + 2M_x)$$

The pressure dependences of C_b^s and C_w^s were calculated from the energies of two E_{2g} modes. Figure 3 shows the pressure dependence of C_b^s in MoS₂, MoS₂, and MoTe₂. The shear force constant C_b^s rapidly increases with pressure, and doubles around 40 kbar and triples around 80 kbar. The intralayer shear force constant C_w^s decreases from MoS₂ to MoTe₂, and the rate of the pressure dependence is small in comparison with C_b^s . Fig-

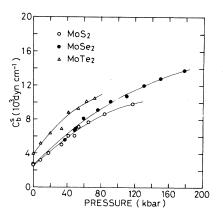


FIG. 3. Pressure dependence of the interlayer shear force constants in MoX_2 .

ure 4 shows the ratio between C_b^s and C_w^s . This ratio rapidly increases with pressure, but its value is only 8% even at 150 kbar in 2*H*-MoSe₂. Therefore these materials still have good two-dimensional character at 150 kbar. In these materials, the sulfide is most layerlike. The ratios between C_b^s and C_w^s in molybdenum dichalcogenides are 1 order larger than that in boron nitride, but the rate of pressure dependence in MoSe₂ and BN is much the same.²⁷

As shown in Table I, the interlayer chalcogen distance is smaller than twice the van der Waals radius of the chalcogen atom. The difference is 0.23 Å in 2*H*-MoS₂, 0.25 Å in 2*H*-MoSe₂, and 0.48 Å in 2*H*-MoTe₂. The larger difference in 2*H*-MoTe₂ is consistent with the larger interlayer shear force constant C_b^s in MoTe₂ as compared with the

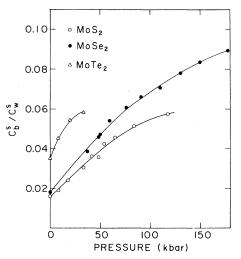


FIG. 4. Pressure dependence of the ratios between the interlayer shear force constants C_b^s and the intralayer shear force constants C_w^s .

other two materials. The large C_b^s and the large transverse effective charge¹⁴ in MoTe₂ may relate to the large polarizability of tellurium atoms.

A direct measurement of the van der Waals gap height by x-ray diffraction has not been made under high pressure. The intralayer height increases with pressure by the model of Webb *et* $al.,^{23}$ but decreases by the model of Bagnall *et al.*¹⁹ Therefore, we could not obtain the interlayer binding potential as a function of the interlayer distance. No evidence of the phase transition was observed in the experimental pressure range.

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